

TPIC1501A QUAD AND HEX POWER DMOS ARRAY

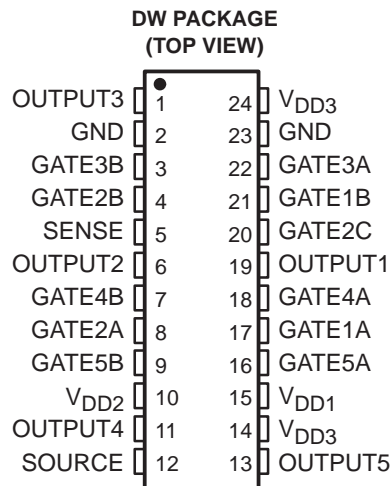
SLIS046A – MAY 1995 – REVISED JUNE 1996

- **Low $r_{DS(on)}$:**
0.1 Ω Typ (Full H-Bridge)
0.4 Ω Typ (Triple Half H-Bridge)
- **Pulsed Current:**
12 A Per Channel (Full H-Bridge)
6 A Per Channel (Triple Half H-Bridge)
- **Matched Sense Transistor for Class A-B Linear Operation**
- **Fast Commutation Speed**

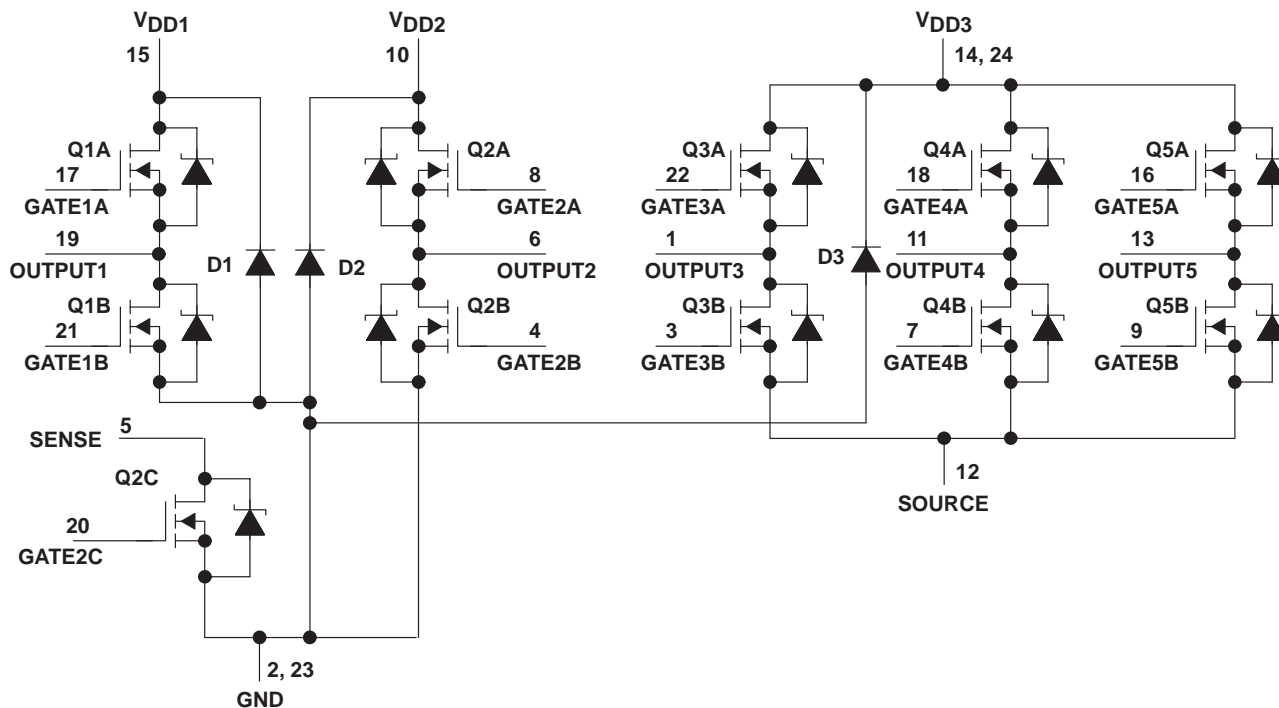
description

The TPIC1501A is a monolithic power array that consists of ten electrically isolated N-channel enhancement-mode power DMOS transistors, four of which are configured as a full H-bridge and six as a triple half H-bridge. The lower stage of the full H-bridge features an integrated sense FET to allow biasing of the bridge in class A-B operation.

The TPIC1501A is offered in a 24-pin wide-body surface-mount (DW) package and is characterized for operation over the case temperature range of -40°C to 125°C .



schematic



- NOTES:
- Pins 2 and 23 must be externally connected.
 - Pins 14 and 24 must be externally connected.
 - No output may be taken greater than 0.5 V below GND.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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TPIC1501A

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absolute maximum ratings, $T_C = 25^\circ\text{C}$ (unless otherwise noted)[†]

Supply-to-GND voltage	20 V
Source-to-GND voltage (Q3A, Q4A, Q5A)	20 V
Output-to-GND voltage	20 V
Sense-to-GND voltage	20 V
Gate-to-source voltage range, V_{GS} (Q1A, Q1B, Q2A, Q2B, Q3A, Q3B, Q4A, Q4B, Q5A, Q5B)	± 20 V
Gate-to-source voltage range, V_{GS} (Q2C)	-0.7 V to 6 V
Continuous drain current, each output (Q1A, Q1B, Q2A, Q2B)	3 A
Continuous drain current, each output (Q3A, Q3B, Q4A, Q4B, Q5A, Q5B)	1.5 A
Continuous drain current (Q2C)	15 mA
Continuous source-to-drain diode current (Q1A, Q1B, Q2A, Q2B)	3 A
Continuous source-to-drain diode current (Q3A, Q3B, Q4A, Q4B, Q5A, Q5B)	1.5 A
Continuous source-to-drain diode current (Q2C)	15 mA
Pulsed drain current, each output, I_{max} (Q1A, Q1B, Q2A, Q2B) (see Note 1 and Figure 24)	12 A
Pulsed drain current, each output, I_{max} (Q3A, Q3B, Q4A, Q4B, Q5A, Q5B) (see Note 1 and Figure 25)	6 A
Pulsed drain current, I_{max} (Q2C) (see Note 1)	60 mA
Continuous total power dissipation, $T_C = 70^\circ\text{C}$ (see Note 2 and Figures 24 and 25)	2.86 W
Operating virtual junction temperature range, T_J	-40°C to 150°C
Operating case temperature range, T_C	-40°C to 125°C
Storage temperature range, T_{stg}	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Pulse duration = 10 ms, duty cycle = 2%
2. Package is mounted in intimate contact with infinite heat sink.

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electrical characteristics, Q1A, Q1B, Q2A, Q2B, $T_C = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage	$I_D = 250\ \mu\text{A}$, $V_{GS} = 0$		20			V
$V_{GS(th)}$	Gate-to-source threshold voltage	$I_D = 1\ \text{mA}$, See Figure 5	$V_{DS} = V_{GS}$	1.4	1.7	2.1	V
$V_{GS(th)match}$	Gate-to-source threshold voltage matching	$I_D = 1\ \text{mA}$, $V_{DS} = V_{GS}$				40	mV
$V_{(BR)}$	Reverse drain-to-GND breakdown voltage	Drain-to-GND current = $250\ \mu\text{A}$ (D1, D2)		20			V
$V_{DS(on)}$	Drain-to-source on-state voltage	$I_D = 2\ \text{A}$, See Notes 3 and 4	$V_{GS} = 10\ \text{V}$		0.2	0.24	V
V_F	Forward on-state voltage, GND-to- V_{DD1} , GND-to- V_{DD2}	$I_D = 3\ \text{A}$ (D1, D2) See Notes 3 and 4			1.8		V
$V_{F(SD)}$	Forward on-state voltage, source-to-drain	$I_S = 2\ \text{A}$, See Notes 3 and 4 and Figure 19	$V_{GS} = 0$		0.85	1.05	V
		$I_S = 3\ \text{A}$, See Notes 3 and 4 and Figure 19	$V_{GS} = 0$		0.9	1.1	
I_{DSS}	Zero-gate-voltage drain current	$V_{DS} = 16\ \text{V}$, $V_{GS} = 0$	$T_C = 25^\circ\text{C}$		0.05	1	μA
			$T_C = 125^\circ\text{C}$		0.5	10	
I_{GSSF}	Forward-gate current, drain short circuited to source	$V_{GS} = 16\ \text{V}$, $V_{DS} = 0$			10	100	nA
I_{GSSR}	Reverse-gate current, drain short circuited to source	$V_{SG} = 16\ \text{V}$, $V_{DS} = 0$			10	100	nA
I_{lkg}	Leakage current, V_{DD1} -to-GND, V_{DD2} -to-GND, gate shorted to source	$V_{DGND} = 16\ \text{V}$	$T_C = 25^\circ\text{C}$		0.05	1	μA
			$T_C = 125^\circ\text{C}$		0.5	10	
$r_{DS(on)}$	Static drain-to-source on-state resistance	$V_{GS} = 10\ \text{V}$, $I_D = 2\ \text{A}$, See Notes 3 and 4 and Figure 9	$T_C = 25^\circ\text{C}$		0.1	0.12	Ω
			$T_C = 125^\circ\text{C}$		0.14	0.18	
		$V_{GS} = 10\ \text{V}$, $I_D = 3\ \text{A}$, See Notes 3 and 4 and Figures 7 and 9	$T_C = 25^\circ\text{C}$		0.1	0.12	
			$T_C = 125^\circ\text{C}$		0.14	0.18	
g_{fs}	Forward transconductance	$V_{DS} = 14\ \text{V}$, See Notes 3 and 4	$I_D = 1\ \text{A}$	1.5	2.5		S
		$V_{DS} = 14\ \text{V}$, See Notes 3 and 4 and Figure 13	$I_D = 1.5\ \text{A}$	2	3.1		
C_{iss}	Short-circuit input capacitance, common source	$V_{DS} = 14\ \text{V}$, $f = 1\ \text{MHz}$, $V_{GS} = 0$, See Figure 17			240		pF
C_{oss}	Short-circuit output capacitance, common source				170		
C_{rss}	Short-circuit reverse transfer capacitance, common source				130		
α_s	Sense-FET drain current ratio	$V_{DS} = 6\ \text{V}$, $I_{D(Q2C)} = 40\ \mu\text{A}$		75	130	200	

NOTES: 3. Technique should limit $T_J - T_C$ to 10°C maximum.

4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

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source-to-drain diode characteristics, Q1A, Q2A, $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{rr} Reverse-recovery time	$I_S = 1.5\text{ A}$, $V_{DS} = 14\text{ V}$, See Figures 1 and 23		70		ns
Q_{RR} Total diode charge			90		nC
t_{rr} Reverse-recovery time	$I_S = 2\text{ A}$, $V_{DS} = 14\text{ V}$		75		ns
Q_{RR} Total diode charge			110		nC

resistive-load switching characteristics, Q1A, Q1B, Q2A, Q2B, $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{d(on)}$ Turn-on delay time	$V_{DD} = 14\text{ V}$, $R_L = 9.3\ \Omega$, $t_{dis} = 10\text{ ns}$, See Figure 3		20		ns
$t_{d(off)}$ Turn-off delay time			30		
t_r Rise time			15		
t_f Fall time			25		
Q_g Total gate charge	$V_{DS} = 14\text{ V}$, See Figure 4	$I_D = 1.5\text{ A}$, $V_{GS} = 10\text{ V}$	5.6	7	nC
$Q_{gs(th)}$ Threshold gate-to-source charge			0.8	1	
Q_{gd} Gate-to-drain charge			1.4	1.75	
$L_{(drain)}$ Internal drain inductance			5		nH
$L_{(source)}$ Internal source inductance			5		
$r_{(gate)}$ Internal gate resistance			0.25		Ω



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electrical characteristics, Q3A, Q3B, Q4A, Q4B, Q5A, Q5B, $T_C = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage	$I_D = 250\ \mu\text{A}$, $V_{GS} = 0\ \text{V}$		20			V
$V_{GS(th)}$	Gate-to-source threshold voltage	$I_D = 1\ \text{mA}$, See Figure 6	$V_{DS} = V_{GS}$,	1.4	1.7	2.1	V
$V_{GS(th)match}$	Gate-to-source threshold voltage matching	$I_D = 1\ \text{mA}$, $V_{DS} = V_{GS}$				40	mV
$V_{(BR)}$	Reverse drain-to-GND breakdown voltage	Drain-to-GND current = $250\ \mu\text{A}$ (D3)		20			V
$V_{DS(on)}$	Drain-to-source on-state voltage	$I_D = 1.5\ \text{A}$, See Notes 3 and 4	$V_{GS} = 10\ \text{V}$,		0.6	0.68	V
V_F	Forward on-state voltage, GND-to- V_{DD3}	$I_D = 1.5\ \text{A}$ (D3) See Notes 3 and 4			1.7		V
$V_F(SD)$	Forward on-state voltage, source-to-drain	$I_S = 1.5\ \text{A}$, See Notes 3 and 4 and Figure 20	$V_{GS} = 0$,		1	1.2	V
		$I_S = 2\ \text{A}$, See Notes 3 and 4 and Figure 20	$V_{GS} = 0$,		1.1	1.3	
I_{DSS}	Zero-gate-voltage drain current	$V_{DS} = 16\ \text{V}$, $V_{GS} = 0$	$T_C = 25^\circ\text{C}$		0.05	1	μA
			$T_C = 125^\circ\text{C}$		0.5	10	
I_{GSSF}	Forward-gate current, drain short circuited to source	$V_{GS} = 16\ \text{V}$,	$V_{DS} = 0$		10	100	nA
I_{GSSR}	Reverse-gate current, drain short circuited to source	$V_{SG} = 16\ \text{V}$,	$V_{DS} = 0$		10	100	nA
I_{lkg}	Leakage current, V_{DD3} -to-GND, gate shorted to source	$V_{DGND} = 16\ \text{V}$	$T_C = 25^\circ\text{C}$		0.05	1	μA
			$T_C = 125^\circ\text{C}$		0.5	10	
$r_{DS(on)}$	Static drain-to-source on-state resistance	$V_{GS} = 10\ \text{V}$, $I_D = 0.3\ \text{A}$, See Notes 3 and 4 and Figure 10	$T_C = 25^\circ\text{C}$		0.35	0.39	Ω
			$T_C = 125^\circ\text{C}$		0.5	0.56	
		$V_{GS} = 10\ \text{V}$, $I_D = 1.5\ \text{A}$, See Notes 3 and 4 and Figures 8 and 10	$T_C = 25^\circ\text{C}$		0.4	0.45	
			$T_C = 125^\circ\text{C}$		0.56	0.65	
g_{fs}	Forward transconductance	$V_{DS} = 14\ \text{V}$, See Notes 3 and 4	$I_D = 500\ \text{mA}$,	0.3	0.8		S
		$V_{DS} = 14\ \text{V}$, See Notes 3 and 4 and Figure 14	$I_D = 750\ \text{mA}$,	0.4	0.93		
C_{iss}	Short-circuit input capacitance, common source	$V_{DS} = 14\ \text{V}$, $f = 1\ \text{MHz}$, $V_{GS} = 0$, See Figure 18			96		pF
C_{oss}	Short-circuit output capacitance, common source				98		
C_{rss}	Short-circuit reverse transfer capacitance, common source				65		

NOTES: 3. Technique should limit $T_J - T_C$ to 10°C maximum.
4. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.



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source-to-drain diode characteristics, Q3A, Q4A, Q5A, $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{rr} Reverse-recovery time	$I_S = 750\text{ mA}$, $V_{DS} = 14\text{ V}$, See Figures 2 and 23		60		ns
Q_{RR} Total diode charge			55		nC
t_{rr} Reverse-recovery time	$I_S = 1.5\text{ A}$, $V_{DS} = 14\text{ V}$, $dI/dt = 100\text{ A}/\mu\text{s}$		120		ns
Q_{RR} Total diode charge			150		nC

resistive-load switching characteristics, Q3A, Q3B, Q4A, Q4B, Q5A, Q5B, $T_C = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{d(on)}$ Turn-on delay time	$V_{DD} = 14\text{ V}$, $R_L = 18.7\ \Omega$, $t_{dis} = 10\text{ ns}$, See Figure 3		18		ns
$t_{d(off)}$ Turn-off delay time			25		
t_r Rise time			13		
t_f Fall time			20		
Q_g Total gate charge	$V_{DS} = 14\text{ V}$, See Figure 4	$I_D = 750\text{ mA}$, $V_{GS} = 10\text{ V}$	1.6	2	nC
$Q_{gs(th)}$ Threshold gate-to-source charge			0.26	0.32	
Q_{gd} Gate-to-drain charge			0.42	0.52	
$L_{(drain)}$ Internal drain inductance			5		nH
$L_{(source)}$ Internal source inductance			5		
$r_{(gate)}$ Internal gate resistance			0.25		Ω

thermal resistance

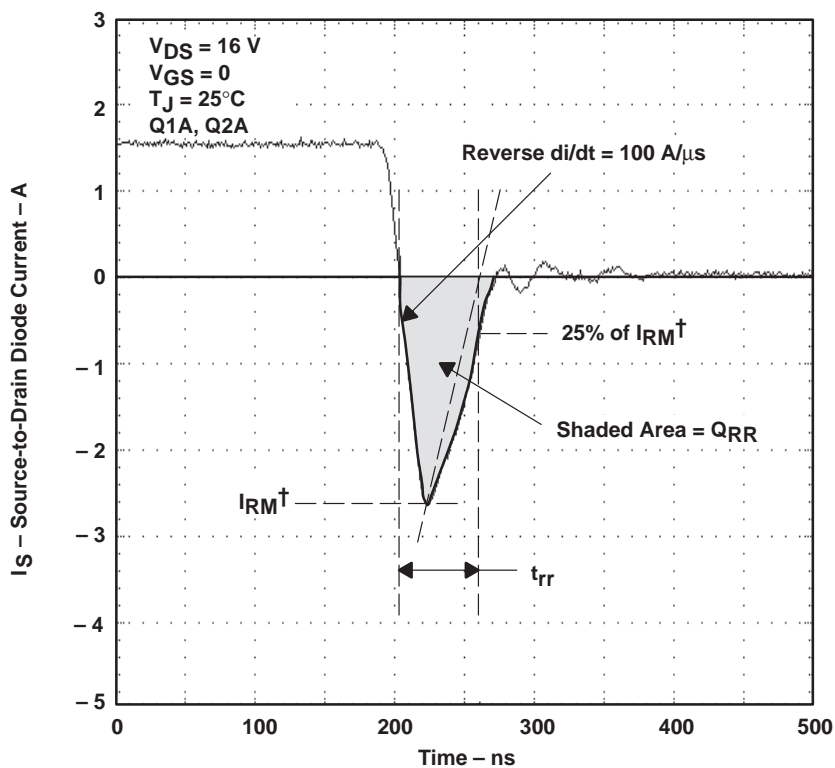
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JA}$ Junction-to-ambient thermal resistance	See Notes 5 and 8		90		$^\circ\text{C}/\text{W}$
$R_{\theta JB}$ Junction-to-board thermal resistance	See Notes 6 and 8		38		
$R_{\theta JP}$ Junction-to-pin thermal resistance	See Notes 7 and 8		28		

NOTES: 5. Package is mounted on a FR4 printed-circuit board with no heat sink.
6. Package is mounted on a 24 in², 4-layer FR4 printed-circuit board.
7. Package is mounted in intimate contact with infinite heat sink.
8. All outputs have equal power.



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PARAMETER MEASUREMENT INFORMATION



$^\dagger I_{RM}$ = maximum recovery current

Figure 1. Reverse-Recovery-Current Waveform of Source-to-Drain Diodes

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PARAMETER MEASUREMENT INFORMATION

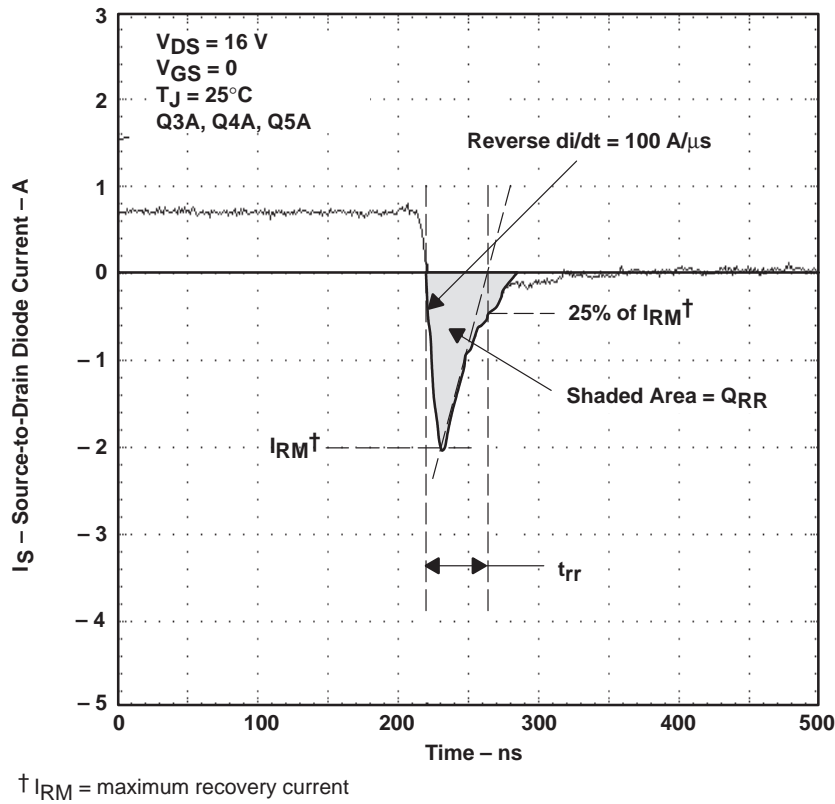
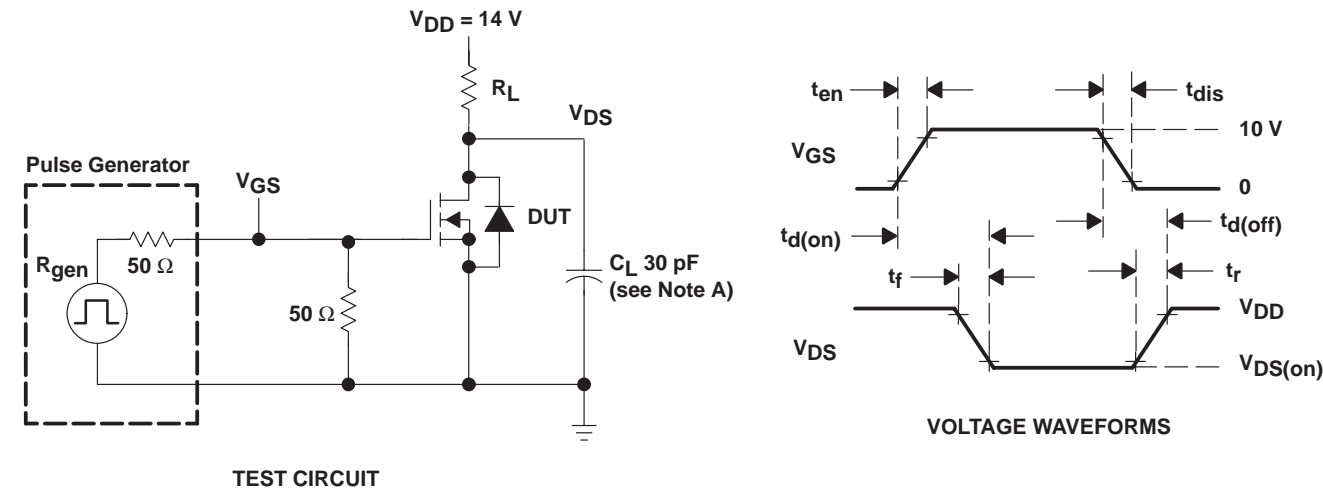


Figure 2. Reverse-Recovery-Current Waveform of Source-to-Drain Diodes



NOTE A: C_L includes probe and jig capacitance.

Figure 3. Resistive-Switching Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION

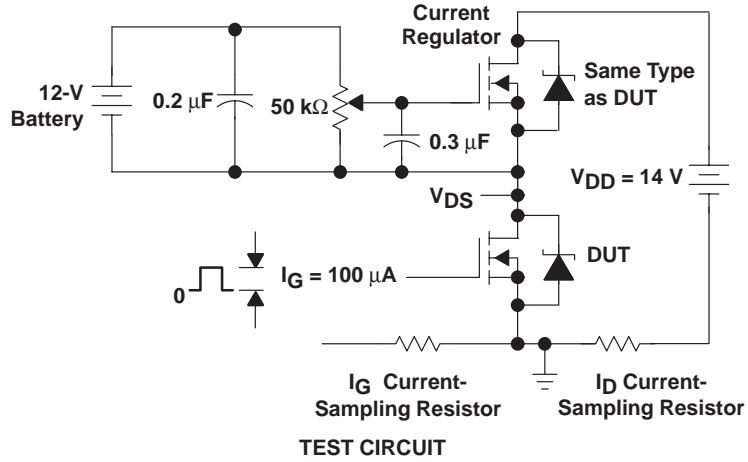


Figure 4. Gate-Charge Test Circuit and Voltage Waveform

TYPICAL CHARACTERISTICS

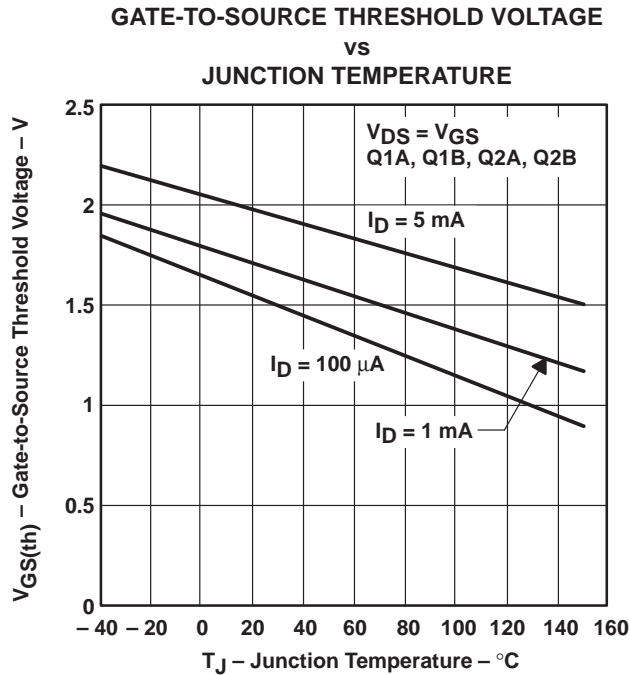


Figure 5

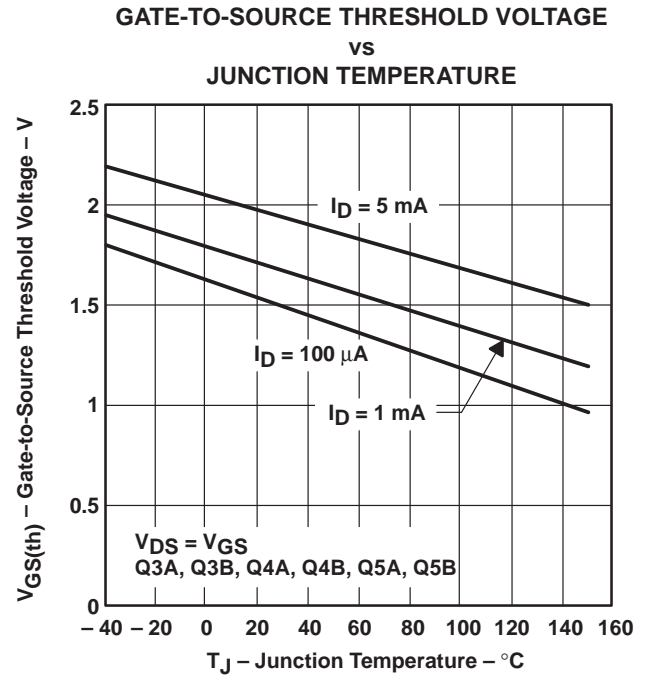


Figure 6

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TYPICAL CHARACTERISTICS

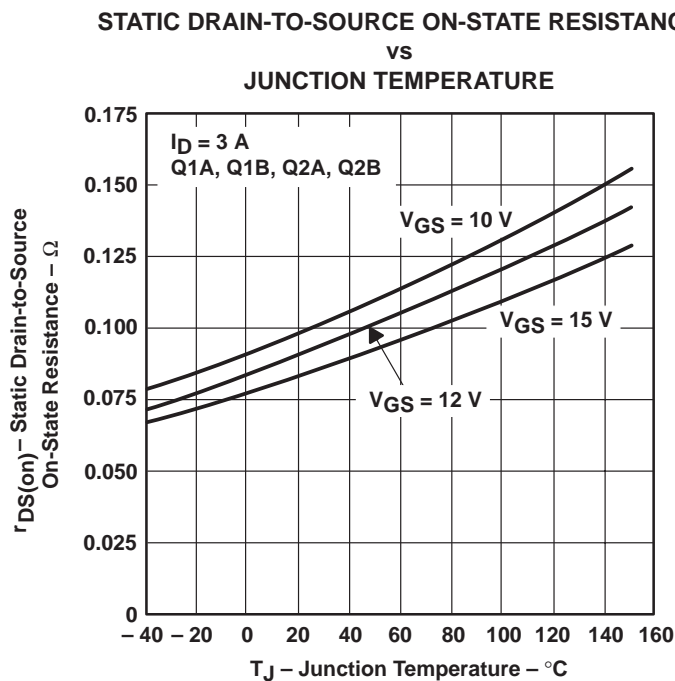


Figure 7

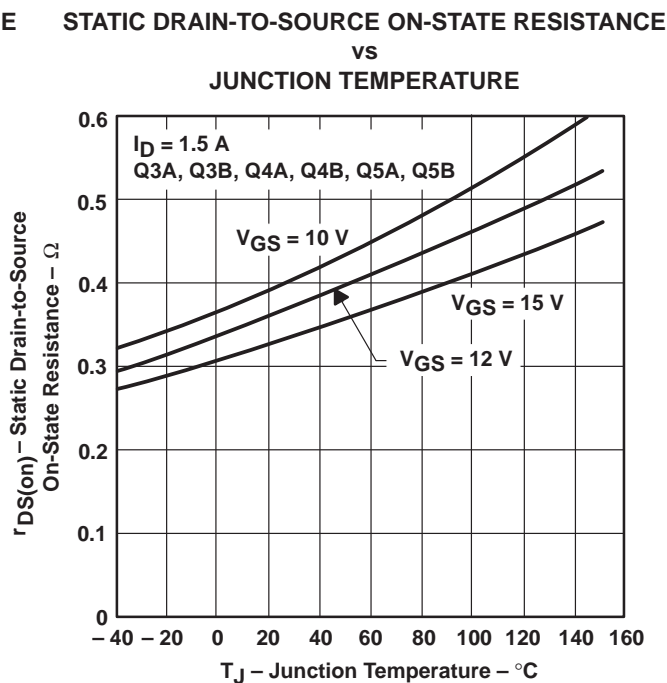


Figure 8

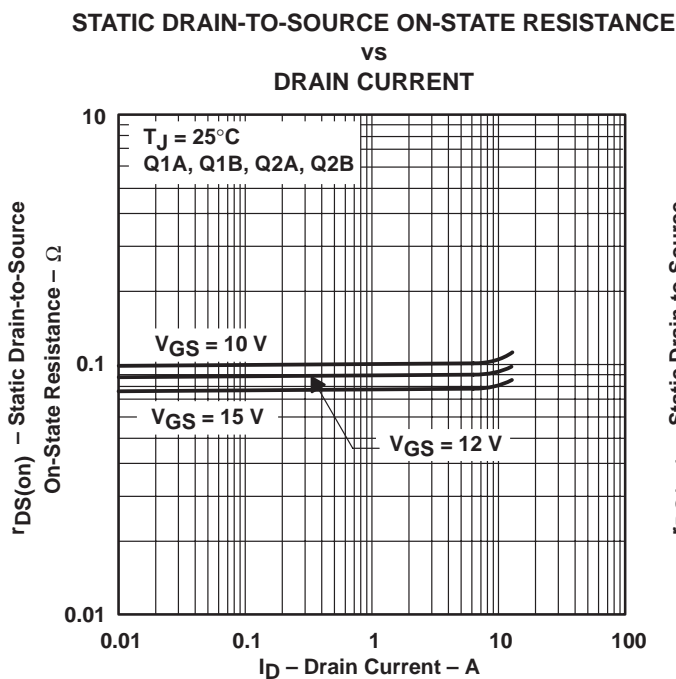


Figure 9

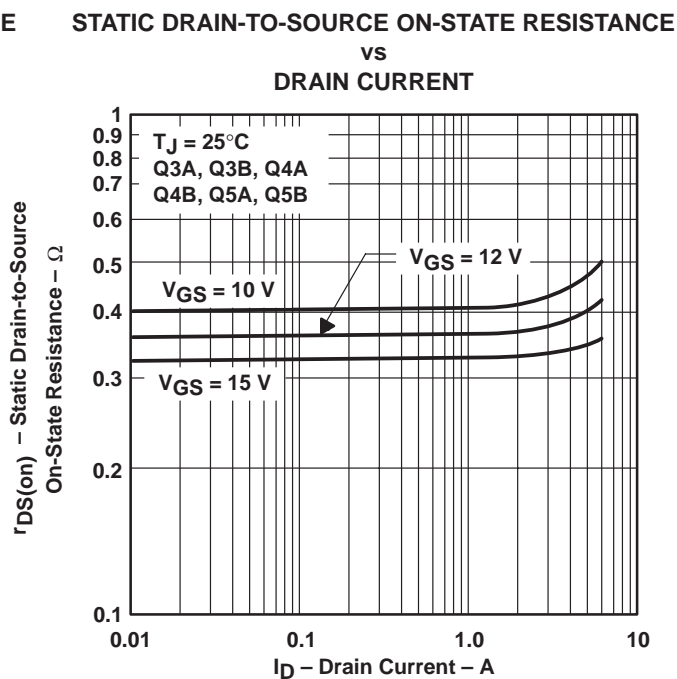


Figure 10

TYPICAL CHARACTERISTICS

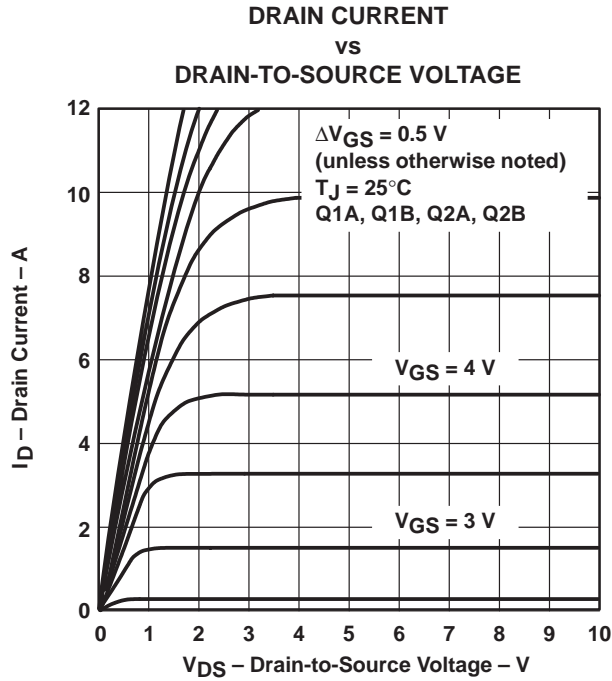


Figure 11

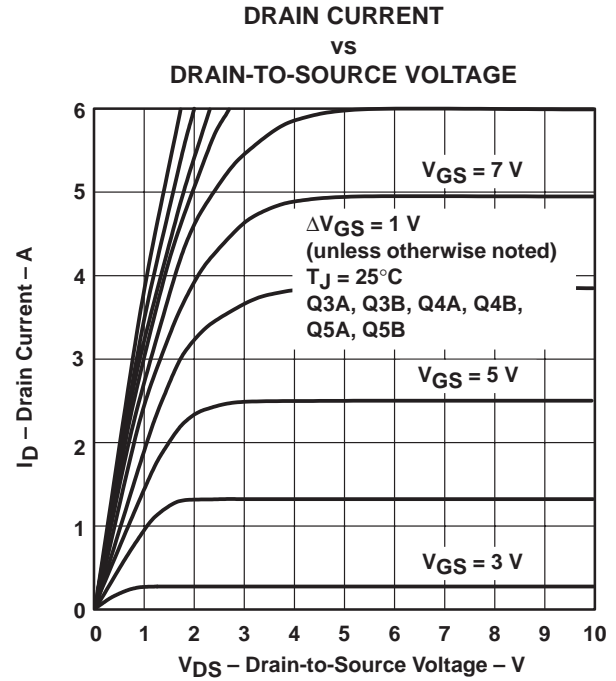


Figure 12

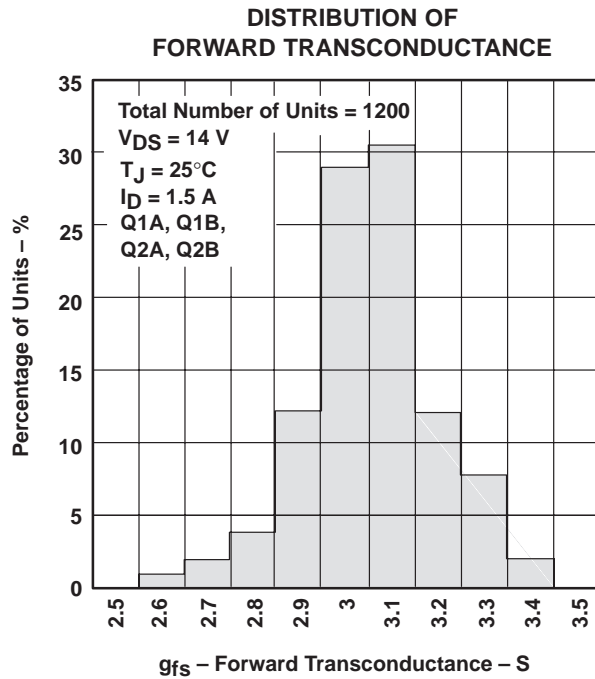


Figure 13

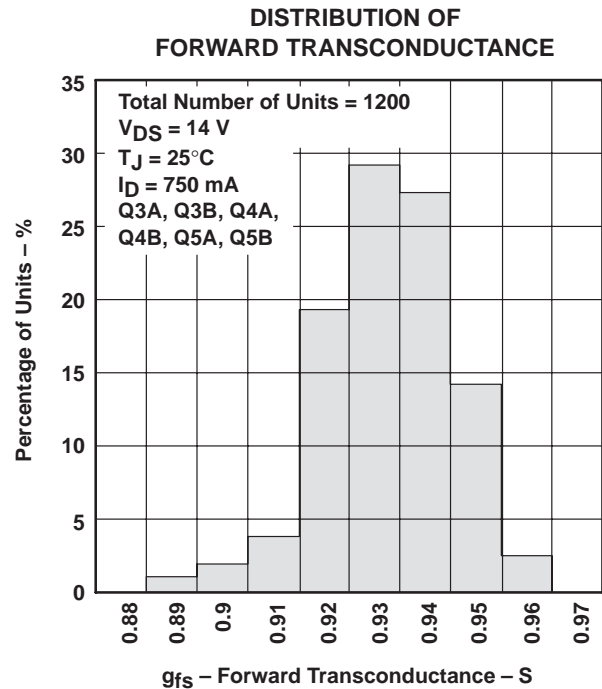


Figure 14

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TYPICAL CHARACTERISTICS

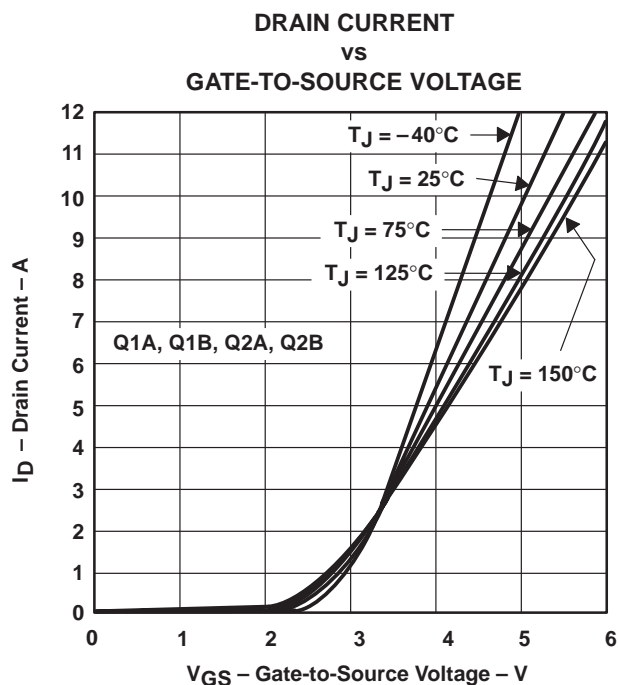


Figure 15

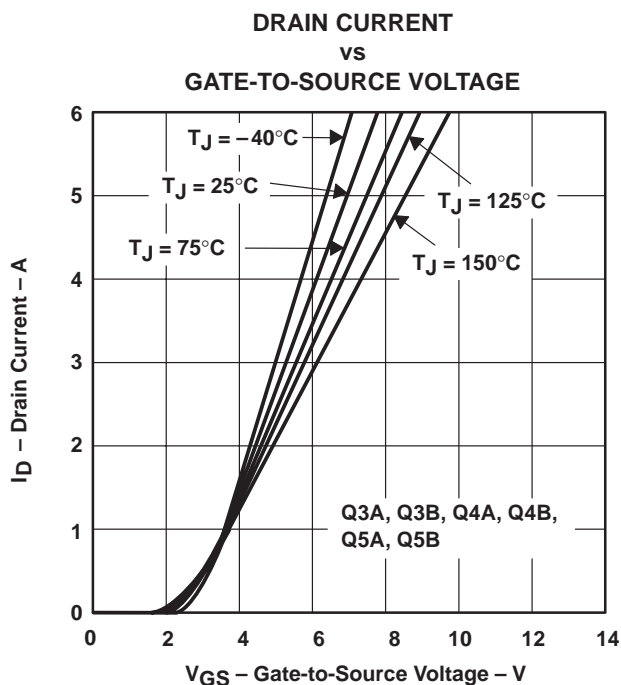


Figure 16

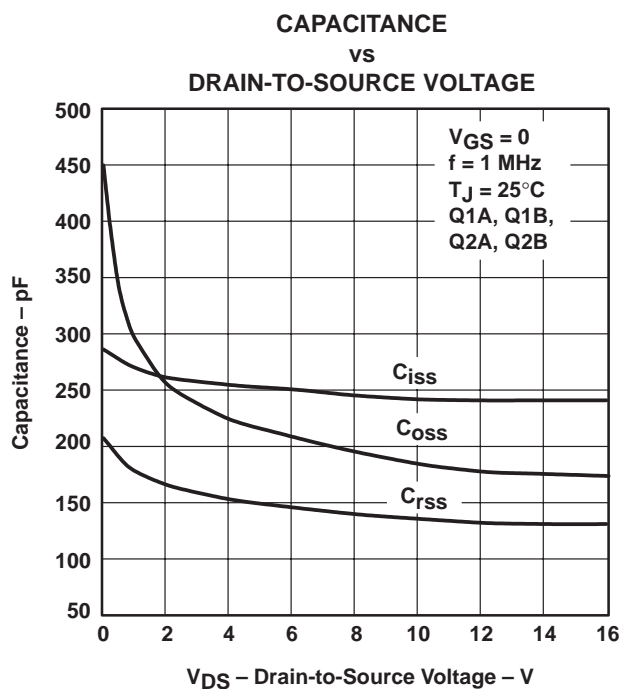


Figure 17

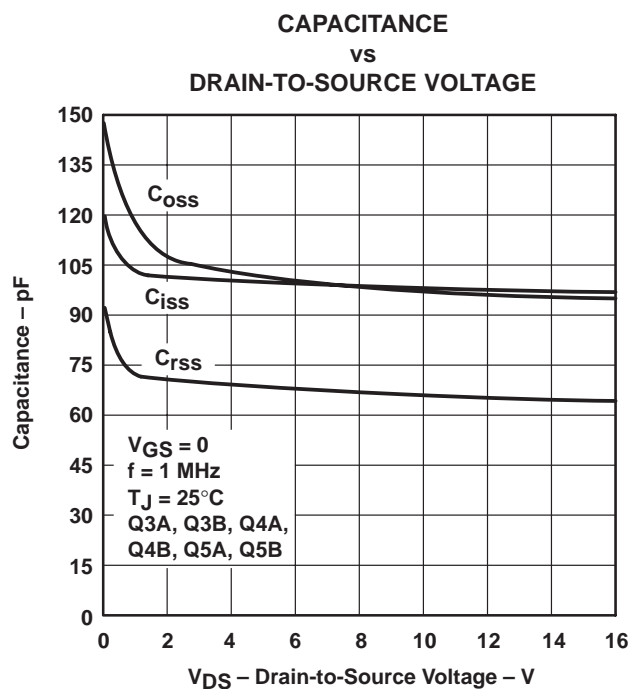


Figure 18

TYPICAL CHARACTERISTICS

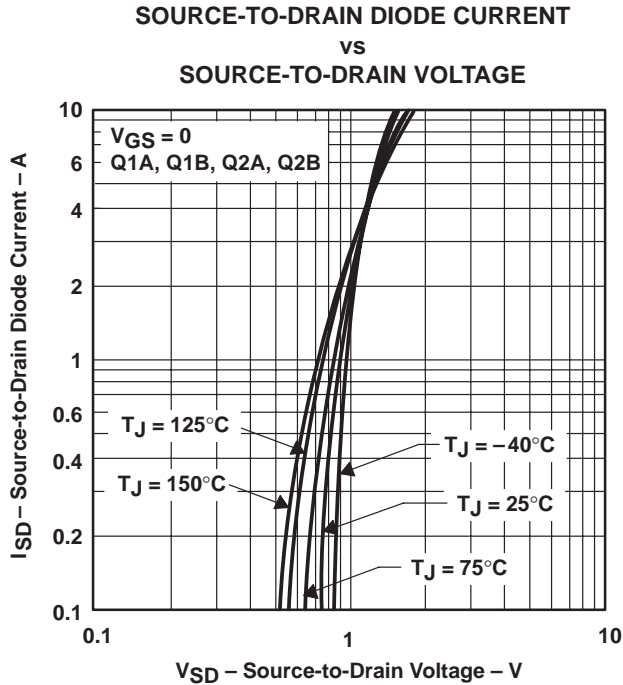


Figure 19

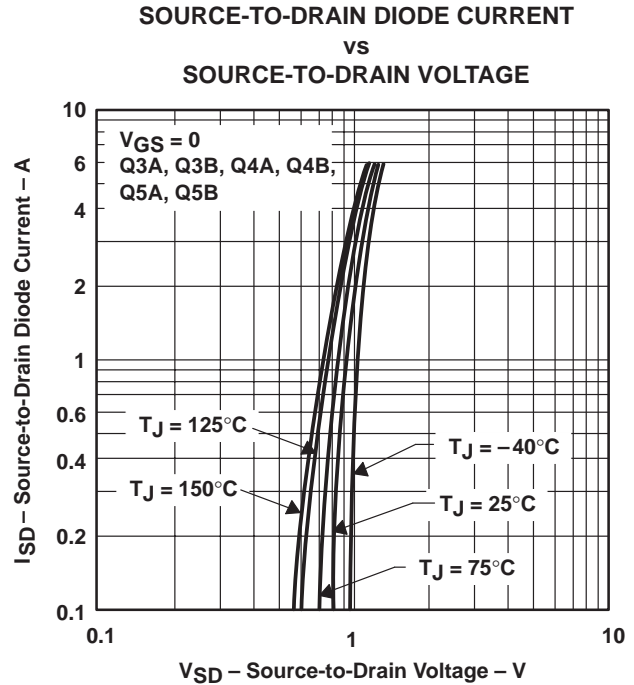


Figure 20

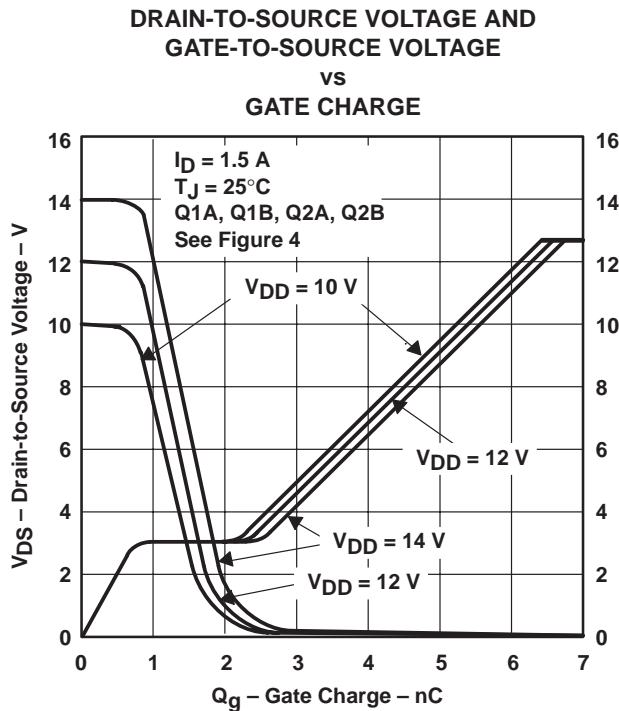


Figure 21

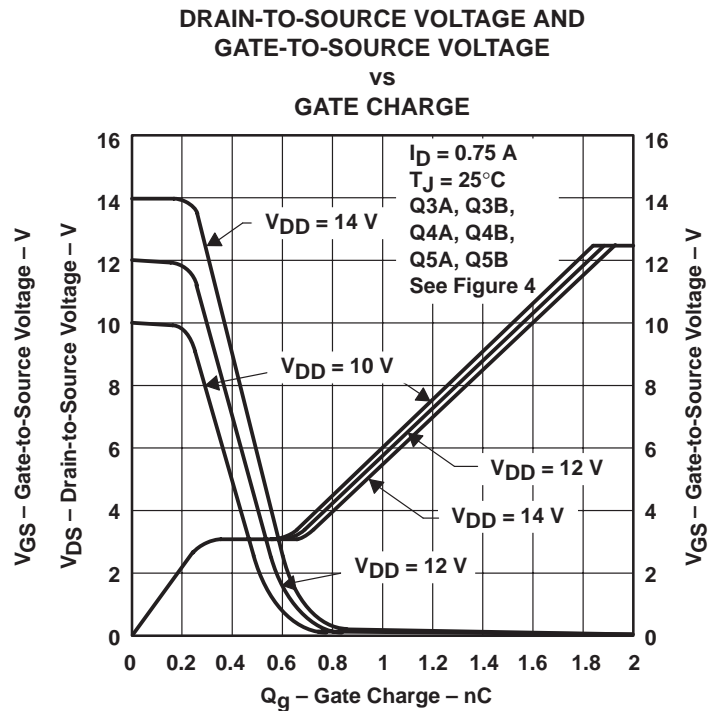


Figure 22

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TYPICAL CHARACTERISTICS

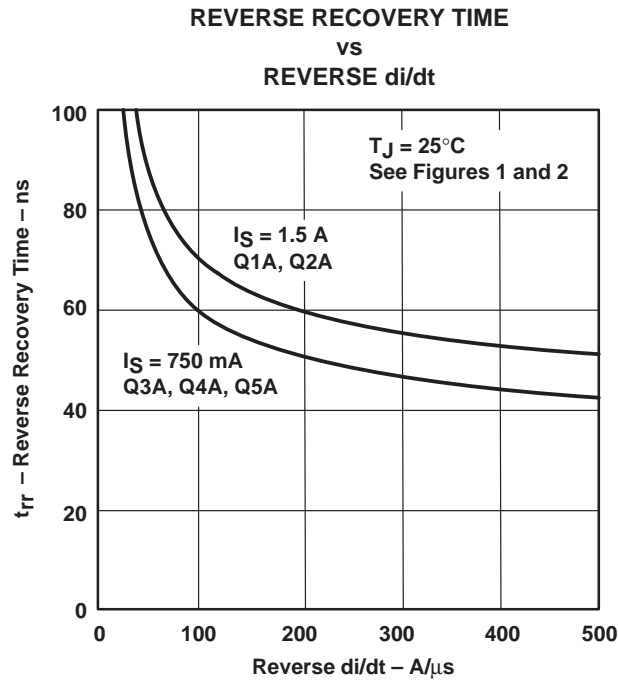


Figure 23

THERMAL INFORMATION

MAXIMUM DRAIN CURRENT vs DRAIN-TO-SOURCE VOLTAGE

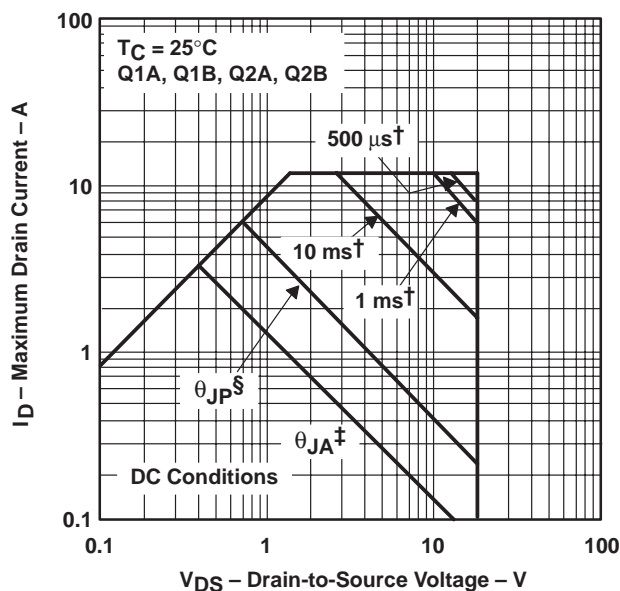


Figure 24

MAXIMUM DRAIN CURRENT vs DRAIN-TO-SOURCE VOLTAGE

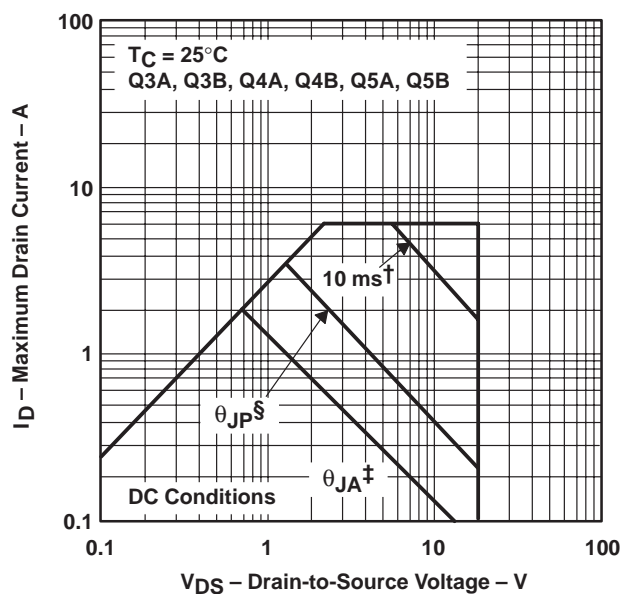


Figure 25

† Less than 10% duty cycle

‡ Device is mounted on a 24 in², 4 layer FR4 printed-circuit board.

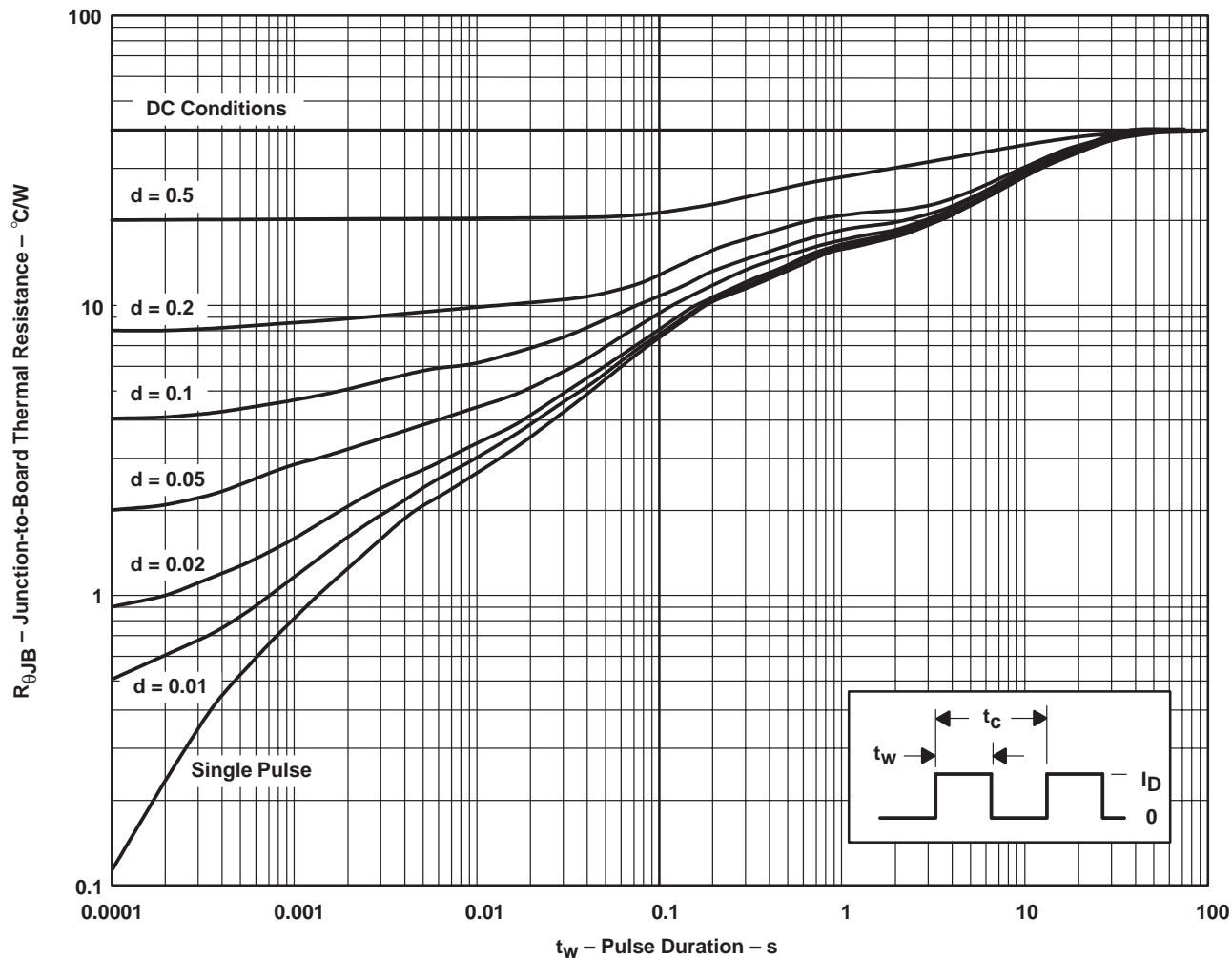
§ Device is mounted in intimate contact with infinite heat sink.

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THERMAL INFORMATION

DW PACKAGE† JUNCTION-TO-BOARD THERMAL RESISTANCE vs PULSE DURATION



† Device is mounted on 24 in², 4-layer FR4 printed-circuit board with no heat sink.

NOTE A: $Z_{\theta B}(t) = r(t) R_{\theta JB}$
 t_W = pulse duration
 t_C = cycle time
 d = duty cycle = t_W/t_C

Figure 26

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TPIC1501ADW	OBSOLETE	SOIC	DW	24		TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

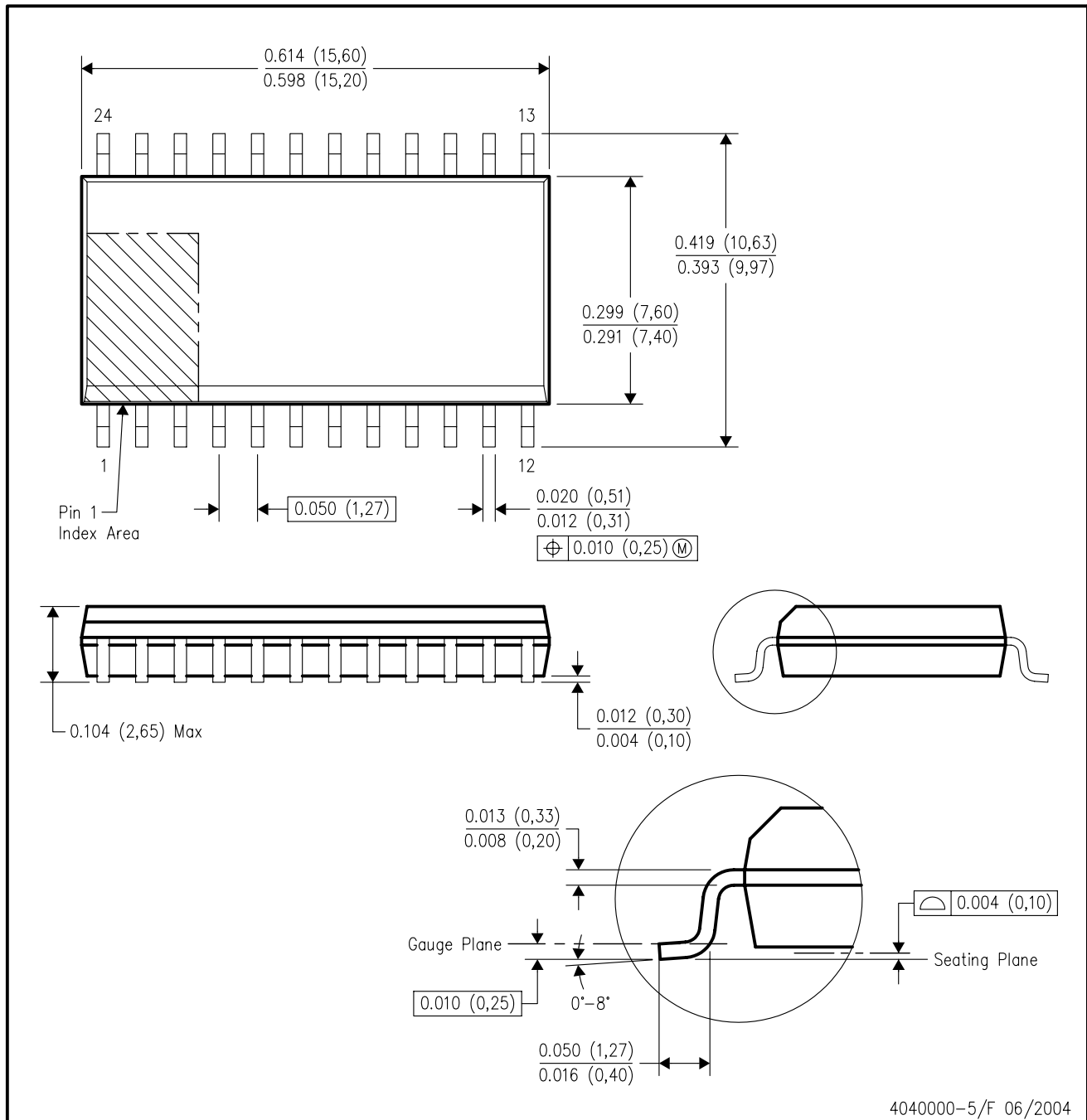
⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DW (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - Falls within JEDEC MS-013 variation AD.

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